

**Search Notes**

Application/Control No.

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Examiner

Nathan Wiehe

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
416	97R	8/23/2005	NEW
415	115	8/23/2005	NEW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
416/97R 415/115 Nihn Nguyen	8/23/2005	NEW
Text Search (See EAST search history)	8/23/2005	NEW
Inventor Name Search	8/23/2005	NEW